


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580727	<b>Applicant(s)/Patent Under Reexamination</b>  STENDER ET AL.
	<b>Examiner</b>  Patricia A Duffy	<b>Art Unit</b>  1645

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
pgpb, uspt, dwpi, jpab, epab	12-6-09	pad
STIC- sequence search	12-6-09	pad
SEQ ID NOS:6, 7 and 8 see score	"	"
STIC SEQ ID NOS:6, 7 and 8 updated - see score	4-12-2010	pad

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	STIC SEQ ID NOS:6, 7, 8, see score	01-2012	pad

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